

# Innovating Energy Technology

http://www.fujielectric.com/products/semiconductor/ **FUJI POWER MOSFET** 

# **Super J-MOS series**

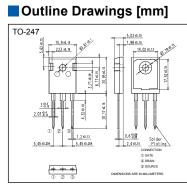
# N-Channel enhancement mode power MOSFET

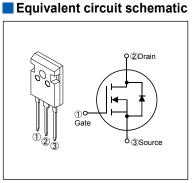
## Features

Pb-free lead terminal **RoHS** compliant uses Halogen-free molding compound

### Applications

For switching





## Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)

Parameter	Symbol	Characteristics	Unit	Remarks
Drain Source Voltage	VDS	600	V	
Drain-Source Voltage	VDSX	600	V	V <sub>GS</sub> =-30V
Continuous Drain Current		±68	А	Tc=25°C Note*1
	lo	±43	А	Tc=100°C Note*1
Pulsed Drain Current	IDP	±204	А	Note*1
Gate-Source Voltage	V <sub>GS</sub>	±30	V	
Repetitive and Non-Repetitive Maximum Avalanche Current	lar	13.5	А	Note *2
Non-Repetitive Maximum Avalanche Energy	Eas	3194.4	mJ	Note *3
Maximum Drain-Source dV/dt	dV <sub>DS</sub> /dt	50	kV/µs	V <sub>DS</sub> ≤ 600V
Peak Diode Recovery dV/dt	dV/dt	15	kV/µs	Note *4
Peak Diode Recovery -di/dt	-di/dt	100	A/µs	Note *5
Maximum Dawar Dissinction	Pp	2.5	W	T <sub>a</sub> =25°C
Maximum Power Dissipation	<b>F</b> D	545	vv	Tc=25°C
One reting and Starsge Temperature range	Tch	150	°C	
Operating and Storage Temperature range	Tstg	-55 to +150	°C	

Note \*1 : Limited by maximum channel temperature. Note \*2 : Tch≤150°C, See Fig.1 and Fig.2 Note \*3 : Starting Tch=25°C, IAs=8.1A, L=89.3mH, Vpp=60V, R₀=50Ω, See Fig.1 and Fig.2

EAs limited by maximum channel temperature and avalanche current. Note \*4 : Ir ≤ -ID, -di/dt=100A/µs, VDs peak ≤ 600V, Tch ≤ 150°C.

Note \*5 : IF  $\leq$  -ID, dV/dt=15kV/µs, VDs peak  $\leq$  600V, T<sub>ch</sub>  $\leq$  150°C.

#### Electrical Characteristics at T<sub>c</sub>=25°C (unless otherwise specified) Static Ratings

Parameter	Symbol	Conditions		min.	typ.	max.	Unit
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	I₀=250μA V <sub>GS</sub> =0V		600	-	-	V
Gate Threshold Voltage	V <sub>GS(th)</sub>	I₀=3.5mA V₀s=V₀s		3	4	5	V
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> =600V V <sub>GS</sub> =0V	T <sub>ch</sub> =25°C	-	-	25	μA
		V <sub>DS</sub> =480V V <sub>GS</sub> =0V	T <sub>ch</sub> =125°C	-	350	-	
Gate-Source Leakage Current	lass	V <sub>GS</sub> = ± 30V V <sub>DS</sub> =0V	,	-	10	100	nA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	I <sub>D</sub> =34A V <sub>GS</sub> =10V		-	0.035	0.042	Ω
Gate resistance	RG	f=1MHz, open drain		-	1.3	-	Ω

#### Dynamic Ratings

Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Forward Transconductance	<b>g</b> fs	I <sub>D</sub> =34A V <sub>DS</sub> =25V	26	53	-	S
Input Capacitance	Ciss	V <sub>DS</sub> =400V	-	5970	-	
Output Capacitance	Coss	V <sub>GS</sub> =0V	-	180	-	
Reverse Transfer Capacitance	Crss	f=250kHz	-	12	-	
Effective output capacitance, energy related (Note *6)	C <sub>o(er)</sub>	V <sub>GS</sub> =0V V <sub>DS</sub> =0400V	-	450	-	pF
Effective output capacitance, time related (Note *7)	C <sub>o(tr)</sub>	V <sub>GS</sub> =0V V <sub>DS</sub> =0400V I <sub>D</sub> =constant	-	1585	-	
Turn-On Time	t <sub>d(on)</sub>		-	186	-	
Turn-On Time	tr	V <sub>DD</sub> =400V, V <sub>GS</sub> =10V I <sub>D</sub> =34A, R <sub>G</sub> =8.2Ω See Fig.3 and Fig.4	-	32	-	- ns
Turn-Off Time	t <sub>d(off)</sub>		-	205	-	
Turn-Off Time			-	20	-	
Total Gate Charge	QG	V₀₀=400V, l₀=68A V₀₅=10V _ See Fig.5	-	209	-	
Gate-Source Charge	Q <sub>GS</sub>		-	53	-	nC
Gate-Drain Charge	Qgd		-	93	-	
Drain-Source crossover Charge	Qsw		-	27	-	1

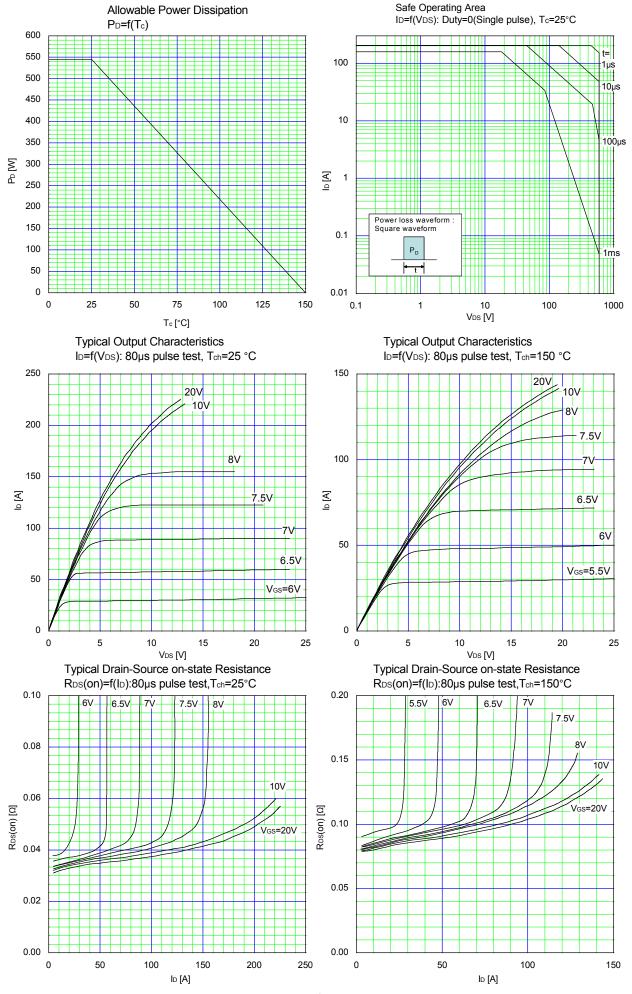
Note \*6 :  $C_{o(er)}$  is a fixed capacitance that gives the same stored energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V. Note \*7 :  $C_{o(tr)}$  is a fixed capacitance that gives the same charging times as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 400V.

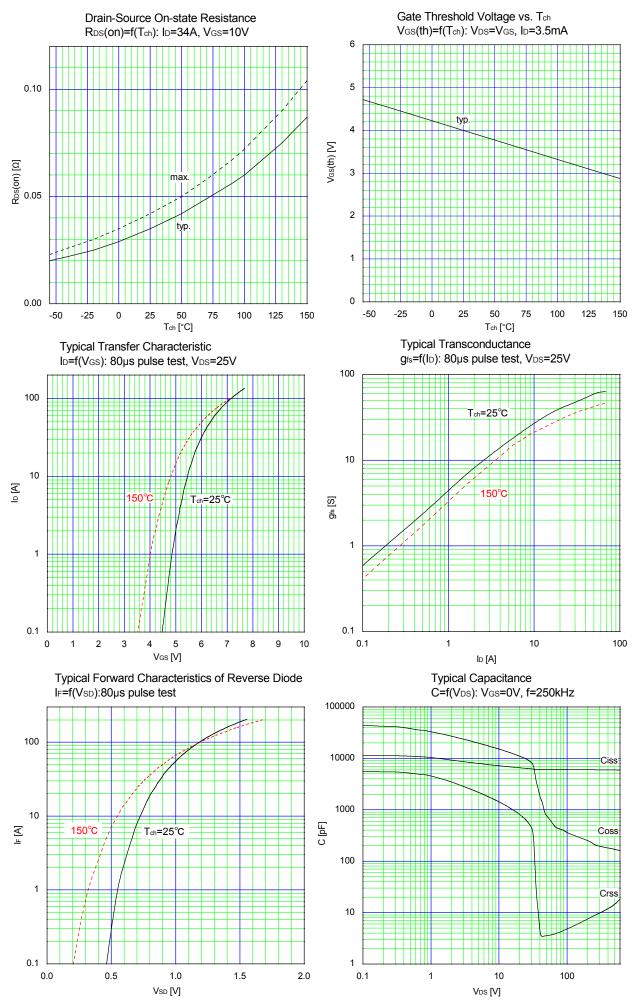
#### Reverse Diode

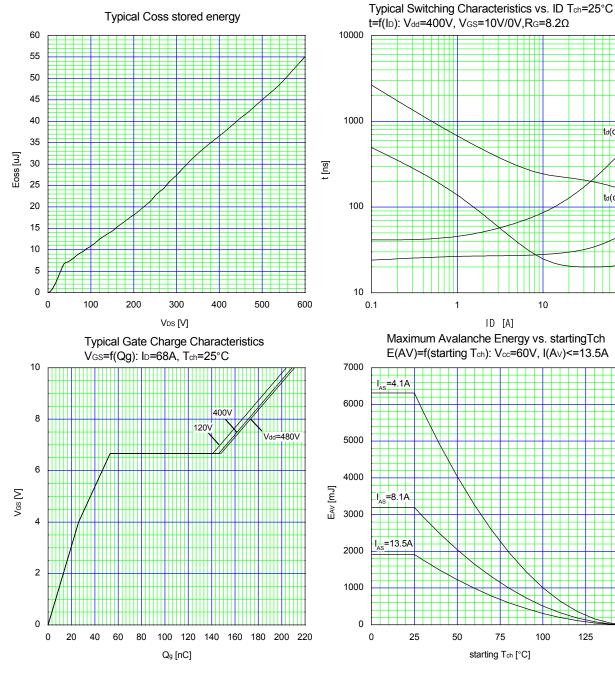
Parameter	Symbol	Conditions	min.	typ.	max.	Unit
Avalanche Capability	lav	L=19.3mH, T₀ =25°C See Fig.1 and Fig.2	13.5	-	-	А
Diode Forward On-Voltage	V <sub>SD</sub>	I⊧=68A, V₀s=0V T₀h=25°C	-	1.1	1.35	V
Reverse Recovery Time	trr	- I⊧=68A, V₀₀=400V -di/dt=100A/µs T₅h=25°C See Fig.6 and Fig.7		230	-	ns
Reverse Recovery Charge	Qrr		-	1.9	-	μC
Peak Reverse Recovery Current	Irp		-	16	-	А

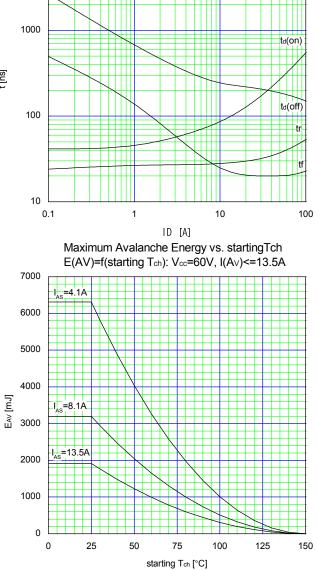
## Thermal Resistance

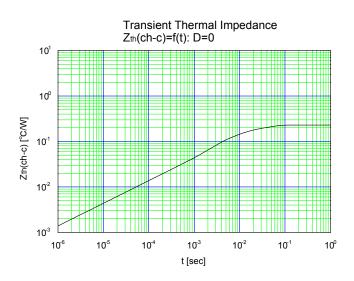
Parameter	Symbol	min.	typ.	max.	Unit
Channel to Case	Rth(ch-c)	-	-	0.23	°C/W
Channel to Ambient	Rth(ch-a)	-	-	50	°C/W











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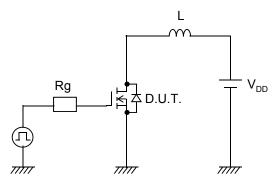


Fig.1 Avalanche Test circuit

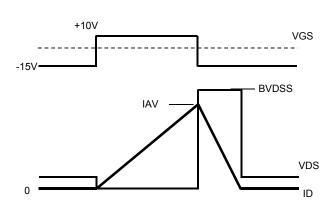
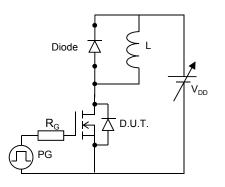


Fig.2 Operating waveforms of Avalanche Test



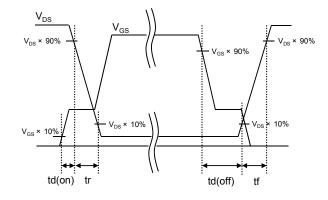


Fig.3 Switching Test circuit

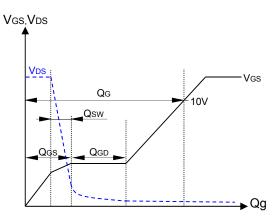


Fig.5 Operating waveform of Gate charge Test

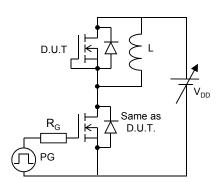
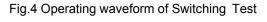


Fig.6 Reverse recovery Test circuit



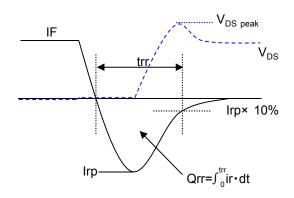
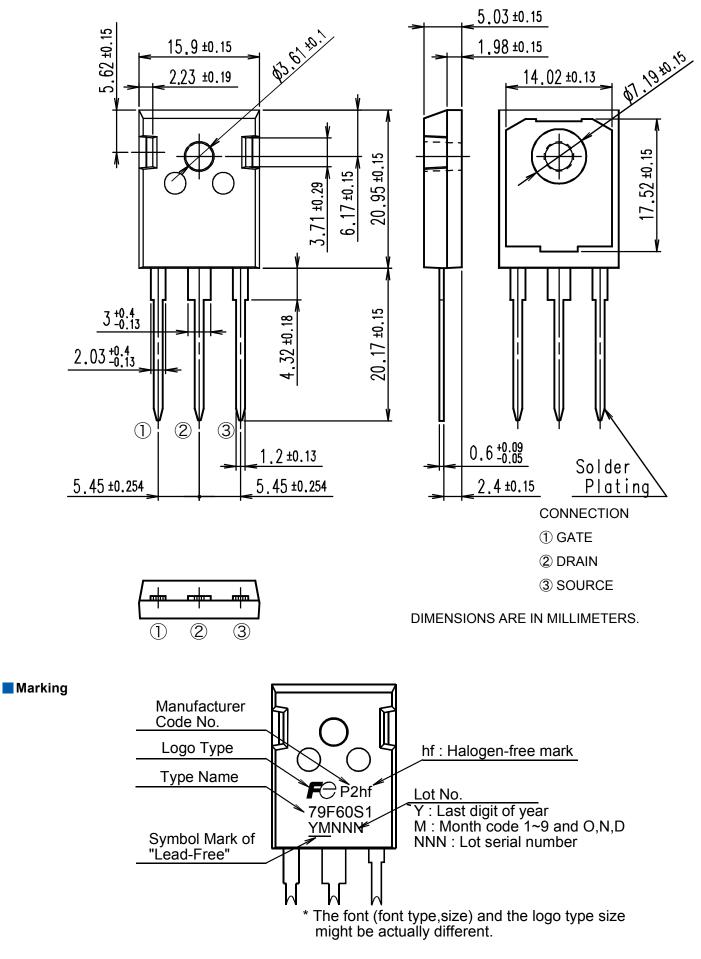


Fig.7 Operating waveform of Reverse recovery Test

## FMW79N60S1FDHF

http://www.fujielectric.com/products/semiconductor/

#### Outview: TO-247 Package



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